# **Power MOSFET**

# 40 V, Single N-Channel, 101 A DPAK

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- MSL 1/260°C
- 100% Avalanche Tested
- NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### **Applications**

- CPU Power Delivery
- DC-DC Converters
- Motor Driver

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage			$V_{DSS}$	40	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	٧
Continuous Drain Cur-		T <sub>C</sub> = 25°C	I <sub>D</sub>	101	Α
rent (R <sub>θJC</sub> ) (Note 1)		T <sub>C</sub> = 85°C		78	
Power Dissipation ( $R_{\theta JC}$ ) (Note 1)	Steady	T <sub>C</sub> = 25°C	$P_{D}$	93.75	W
Continuous Drain Cur-	State	T <sub>A</sub> = 25°C	I <sub>D</sub>	16.4	Α
rent (R <sub>θJA</sub> ) (Note 1)		T <sub>A</sub> = 85°C		12.7	
Power Dissipation $(R_{\theta JA})$ (Note 1)		T <sub>A</sub> = 25°C	$P_{D}$	2.5	W
Pulsed Drain Current	t <sub>p</sub> =10μs	T <sub>A</sub> = 25°C	I <sub>DM</sub>	300	Α
Current Limited by Pack	I <sub>DmaxPkg</sub>	45	Α		
Operating Junction and	T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C		
Source Current (Body Diode)			Is	50	Α
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to-Source Avalanche Energy ( $V_{DD}$ = 32 V, $V_{GS}$ = 10 V, L = 0.3 mH, $I_{L(pk)}$ = 40 A, $R_{G}$ = 25 $\Omega$ )			E <sub>AS</sub>	240	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			$T_L$	260	°C

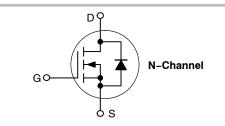
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



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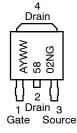
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>	
40 V	4.4 mΩ @ 10 V	101 A	
	7.8 m $\Omega$ @ 5.0 V	50 A	





#### **MARKING DIAGRAMS & PIN ASSIGNMENT**

STYLE 2



= Assembly Location\*

= Year ww = Work Week 5802N = Device Code = Pb-Free Package

\* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

#### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	1.6	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	60	
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	105	

<sup>1.</sup> Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>1</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				•	•	•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 10 μA		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				40		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 40 V	$T_{J} = 25^{\circ}C$ $T_{J} = 150^{\circ}C$			1.0 50	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>G</sub>	<sub>S</sub> = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)	<u> </u>				l		•
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub>	= 250 μΑ	1.5		3.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-7.4		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 \text{ V}, I_D = 50 \text{ A}$			3.6	4.4	mΩ
	V <sub>GS</sub> = 5.0 V, I <sub>D</sub> = 50 A			6.5	7.8		
Forward Transconductance	gFS	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A			16.8		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 12 \text{ V}$			5300		pF
Output Capacitance	C <sub>oss</sub>				850		
Reverse Transfer Capacitance	C <sub>rss</sub>				550		
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 25 V			5025		pF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 2	5 V		580		
Reverse Transfer Capacitance	C <sub>rss</sub>				400		
Total Gate Charge	Q <sub>G(TOT)</sub>				75	100	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 10 V, V	<sub>DS</sub> = 15 V,		6.0		
Gate-to-Source Charge	Q <sub>GS</sub>	I <sub>D</sub> = 50	Ā		18		
Gate-to-Drain Charge	$Q_{GD}$				15		
SWITCHING CHARACTERISTICS (Not	e 4)						
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 20 V, $I_{D}$ = 50 A, $R_{G}$ = 2.0 $\Omega$			14		ns
Rise Time	t <sub>r</sub>				52		
Turn-Off Delay Time	t <sub>d(off)</sub>				39		1
Fall Time	t <sub>f</sub>				8.5		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

<sup>2.</sup> Surface-mounted on FR4 board using the minimum recommended pad size.

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted) (continued)

	-	,	,				
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS							
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 50 A	T <sub>J</sub> = 25°C		0.9	1.2	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 20 A	T <sub>J</sub> = 25°C		0.8	1.0	
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS}$ = 0 V, dls/dt = 100 A/ $\mu$ s, $I_S$ = 50 A			25		ns
Charge Time	ta				15		
Discharge Time	tb				10		]
Reverse Recovery Charge	Q <sub>RR</sub>				15		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

4. Switching characteristics are independent of operating junction temperatures.

#### TYPICAL PERFORMANCE CHARACTERISTICS

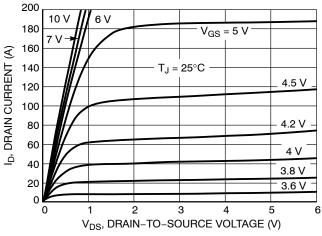


Figure 1. On-Region Characteristics

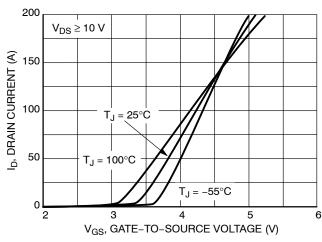


Figure 2. Transfer Characteristics

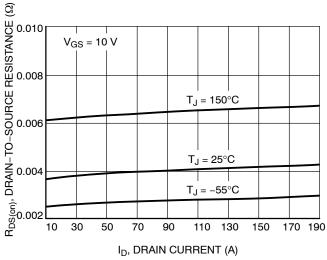


Figure 3. On-Resistance vs. Drain Current

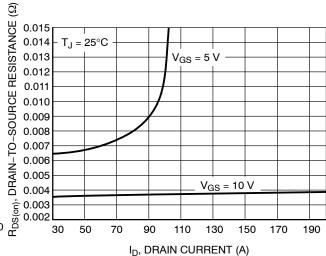


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

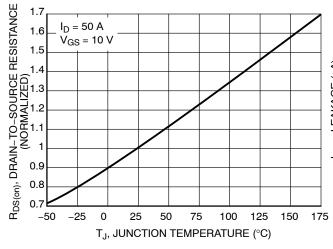


Figure 5. On–Resistance Variation with Temperature

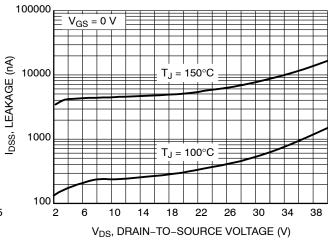


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### TYPICAL PERFORMANCE CHARACTERISTICS

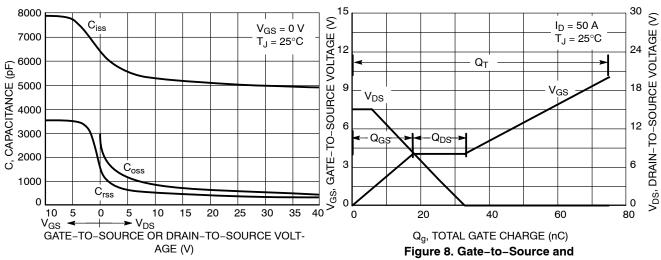


Figure 7. Capacitance Variation

Drain-to-Source Voltage vs. Total Charge

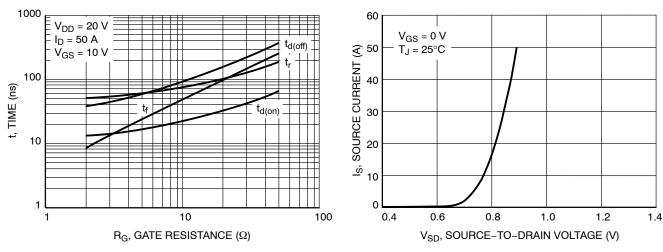


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

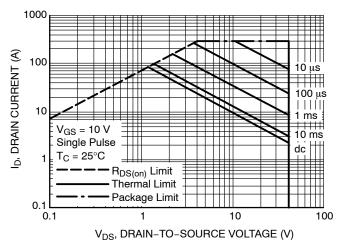


Figure 11. Maximum Rated Forward Biased Safe Operating Area

#### **TYPICAL PERFORMANCE CHARACTERISTICS**

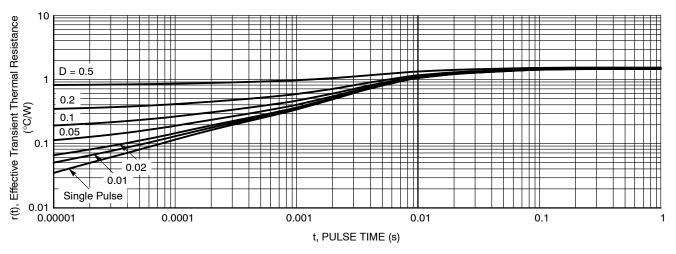


Figure 12. Thermal Response

#### **ORDERING INFORMATION**

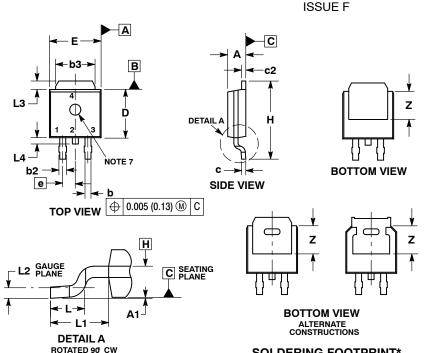
Order Number	Package	Shipping <sup>†</sup>
NTD5802NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NVD5802NT4G*	DPAK (Pb-Free)	2500 / Tape & Reel
NVD5802NT4G-VF01	DPAK (Pb-Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging

Specifications Brochure, BRD8011/D.
\*NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.

#### PACKAGE DIMENSIONS

#### **DPAK (SINGLE GAUGE)** CASE 369C



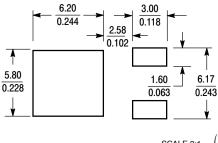
- NOTES:

  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DI-
- MENSIONS b3, L3 and Z.
  DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
  5. DIMENSIONS D AND E ARE DETERMINED AT THE
- OUTERMOST EXTREMES OF THE PLASTIC BODY.
  6. DATUMS A AND B ARE DETERMINED AT DATUM
- PLANE H.
  7. OPTIONAL MOLD FEATURE.

	INCHES		MILLIM	ETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.028	0.045	0.72	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29 BSC		
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.114	0.114 REF		2.90 REF	
L2	0.020 BSC		0.51 BSC		
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

- STYLE 2: PIN 1. GATE
  - 2. DRAIN 3. SOURCE
  - 4. DRAIN

# **SOLDERING FOOTPRINT\***



mm SCALE 3:1

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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